INTEGRATED CIRCUITS



Product specification

1988 Nov 01

IC15 Data Handbook



PHILIPS

Philips Semiconductors

74F393

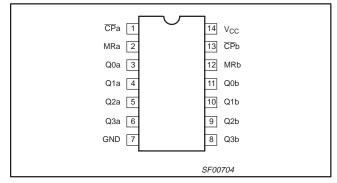
FEATURES

- Two 4-bit binary counters
- Two Master Resets to clear each 4-bit counter individually

DESCRIPTION

The 74F393 is a Dual Ripple Counter with separate Clock (\overline{CP}_n) and Master Reset (MR) inputs to each counter. The two counters are identified by the "a" and "b" suffixes in the pin configuration. The operation of each half of the 74F393 is the same. The counters are triggered by a High-to-Low transition of the Clock (\overline{CP}_a and \overline{CP}_b) inputs. The counter outputs are internally connected to provide Clock inputs to succeeding stages. The outputs of the ripple counter do not change synchronously and should not be used for high speed address decoding. The Master Resets (MR_a and MR_b) are active High asynchronous inputs; one for each 4-bit counter. A High level in the MR input overrides the Clock and sets the outputs Low.

PIN CONFIGURATION



TYPE	TYPICAL f _{MAX}	TYPICAL SUPPLY CURRENT (TOTAL)
74F393	125MHz	40mA

ORDERING INFORMATION

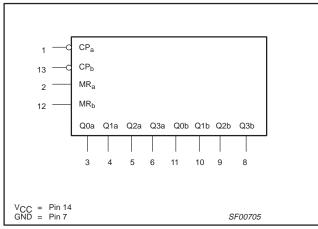
DESCRIPTION	$\begin{array}{l} \text{COMMERCIAL RANGE} \\ \text{V}_{CC} = 5\text{V} \pm 10\%, \\ \text{T}_{amb} = 0^{\circ}\text{C to } + 70^{\circ}\text{C} \end{array}$	PKG DWG #		
14-pin plastic DIP	N74F393N	SOT27-1		
14-pin plastic SO	N74F393D	SOT108-1		

INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

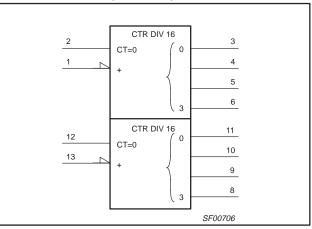
PINS	DESCRIPTION	74F (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW		
CP _a , CP _b	Clock inputs	1.0/1.0	20µA/0.6mA		
MR _a , MR _b	Master Reset inputs	1.0/1.0	20µA/0.6mA		
Q _{na} – Q _{nb}	Data outputs	50/33.3	1.0mA/20mA		

NOTE: One (1.0) FAST unit load is defined as: 20µA in the High state and 0.6mA in the Low state.

LOGIC SYMBOL

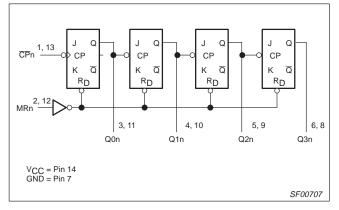


IEC/IEEE SYMBOL (IEEE/IEC)



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LOGIC DIAGRAM



COUNT		OUTI	PUTS	
COONT	Q _{0n}	Q _{1n}	Q _{2n}	Q _{3n}
0	L	L	L	L
1	н	L	L	L
2	L	Н	L	L
3	н	Н	L	L
4	L	L	Н	L
5	н	L	Н	L
6	L	Н	Н	L
7	н	Н	Н	L
8	L	L	L	Н
9	н	L	L	Н
10	L	Н	L	Н
11	н	Н	L	Н
12	L	L	Н	Н
13	н	L	Н	Н
14	L	Н	Н	н
15	н	Н	Н	Н

H = High voltage level transition L = Low voltage level

FUNCTION TABLE

ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limits set forth in this table may impair the useful life of the device. Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT	
V _{CC}	Supply voltage	-0.5 to +7.0	V	
V _{IN}	Input voltage	-0.5 to +7.0	V	
I _{IN}	Input current	-30 to +5	mA	
V _{OUT}	Voltage applied to output in High output state	–0.5 to V_{CC}	V	
I _{OUT}	Current applied to output in Low output state	40	mA	
T _{amb}	Operating free-air temperature range	0 to +70	°C	
T _{stg}	Storage temperature range	-65 to +150	°C	

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER				
STWBOL	PARAMETER	MIN	NOM	MAX	UNIT
V _{CC}	Supply voltage	4.5	5.0	5.5	V
V _{IH}	High-level input voltage	2.0			V
V _{IL}	Low-level input voltage			0.8	V
I _{IK}	Input clamp current			-18	mA
I _{OH}	High-level output current			-1	mA
I _{OL}	Low-level output current			20	mA
T _{amb}	Operating free-air temperature range	0		70	°C

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DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

SYMBOL	PARAMETER		TEST CONDITIONS ¹			LIMITS			
STMBUL	PARAMETER	TEST CONDITIO	MIN	TYP ²	MAX	UNIT			
M		$V_{CC} = MIN, V_{IL} = MAX$	±10%V _{CC}	2.5					
V _{OH}	High-level output voltage	$V_{IH} = MIN, I_{OH} = MAX$	±5%V _{CC}	2.7	3.4		V		
M		$V_{CC} = MIN, V_{IL} = MAX$	$\pm 10\% V_{CC}$		0.30	0.50	V		
V _{OL}	Low-level output voltage	$V_{IH} = MIN, I_{OL} = MAX$	±5%V _{CC}		0.30	0.50	v		
V _{IK}	Input clamp voltage	$V_{CC} = MIN, I_I = I_{IK}$			-0.73	-1.2	V		
l _l	Input current at maximum input v	voltage	$V_{CC} = MAX, V_I = 7.0V$			100	μΑ		
I _{IH}	High-level input current		$V_{CC} = MAX, V_I = 2.7V$				20	μΑ	
IIL	Low-level input current		$V_{CC} = MAX, V_I = 0.5V$				-0.6	mA	
I _{OS}	Short-circuit output current ³		V _{CC} = MAX		-60		-150	mA	
	Supply current (total)	I _{CCH}				25	36	mA	
Icc	Supply current (total)	I _{CCL}	$V_{CC} = MAX$		42	58	mA		

NOTES:

1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.

2. All typical values are at $V_{CC} = 5V$, $T_{amb} = 25^{\circ}C$. 3. Not more than one output should be shorted at a time. For testing I_{OS} , the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I_{OS} tests should be performed last.

AC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER	TEST CONDITION	V T _{ai} C _L = 5	/ _{CC} = +5\ _{mb} = +25 0pF, R _L =	/ °C = 500Ω	V _{CC} = +5 T _{amb} = 0°C C _L = 50pF,	UNIT	
			MIN	TYP	MAX	MIN	MAX	
f _{MAX}	Maximum clock frequency	Waveform 1	100	130		100		MHz
t _{PLH} t _{PHL}	Propagation delay CPn to Q0a or Q0b	Waveform 1	3.5 5.0	5.5 7.0	8.0 10.0	3.5 5.0	9.0 10.5	ns
t _{PLH} t _{PHL}	Propagation delay CPn to Q1a, Q1b	Waveform 1	5.0 7.5	7.0 9.5	10.0 12.0	4.5 7.0	13.0 13.0	ns
t _{PLH} t _{PHL}	Propagation delay CPn to Q2a, Q2b	Waveform 1	8.0 9.5	10.0 11.5	13.0 14.5	7.0 9.0	15.0 15.5	ns
t _{PLH} t _{PHL}	Propagation delay CPn to Q3a, Q3b	Waveform 1	10.5 12.0	12.5 14.0	15.5 16.5	10.0 11.5	17.0 17.5	ns
t _{PHL}	Propagation delay MR to Qna, Qnb	Waveform 2	4.0	6.0	9.0	4.0	9.0	ns

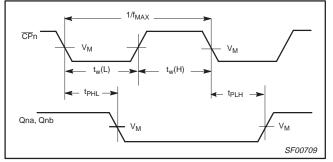
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AC SETUP REQUIREMENTS

		TEST CONDITION						
SYMBOL	PARAMETER		V _{CC} = +5V T _{amb} = +25°C C _L = 50pF, R _L = 500Ω			V _{CC} = +5 T _{amb} = 0°C C _L = 50pF,	UNIT	
			MIN	TYP	MAX	MIN	MAX	
t _W (H) t _W (L)	CPn Pulse width High or Low	Waveform 1	4.5 3.5			5.0 4.0		ns
t _W (H)	MR Pulse width High	Waveform 2	3.5			4.5		ns
tREC	Recovery time MR to CPn	Waveform 2	2.5			3.0		ns

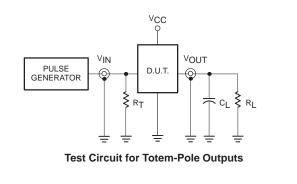
AC WAVEFORMS

For all waveforms, $V_M = 1.5V$.



Waveform 1. Propagation Delay, Clock Input to Output, Clock Pulse Width, and Maximum Clock Frequency

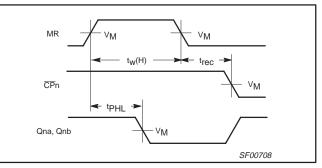
TEST CIRCUIT AND WAVEFORMS



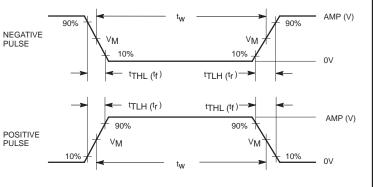
DEFINITIONS:

R_L = Load resistor;

- C_L = Load capacitance includes jig and probe capacitance; see AC ELECTRICAL CHARACTERISTICS for value.
- R_T = Termination resistance should be equal to Z_{OUT} of pulse generators.



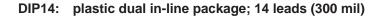
Waveform 2. Master Reset Pulse Width, Master Reset to Output Delay, and Master Reset to Clock Recovery Time

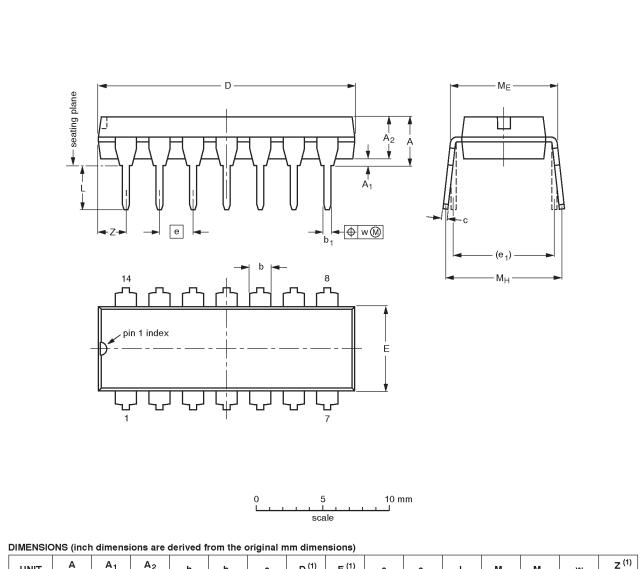


Input Pulse Definition

family	INPUT PULSE REQUIREMENTS									
	amplitude	V _M	rep. rate	tw	t _{TLH}	t _{THL}				
74F	3.0V	1.5V	1MHz	500ns	2.5ns	2.5ns				

SF00006





UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	c	D ⁽¹⁾	E ⁽¹⁾	e	e ₁	L	ME	м _н	w	Z ⁽¹⁾ max.
mm	4.2	0.51	3.2	1.73 1.13	0.53 0.38	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.2
inches	0.17	0.020	0.13	0.068 0.044	0.021 0.015	0.014 0.009	0.77 0.73	0.26 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.087

Note

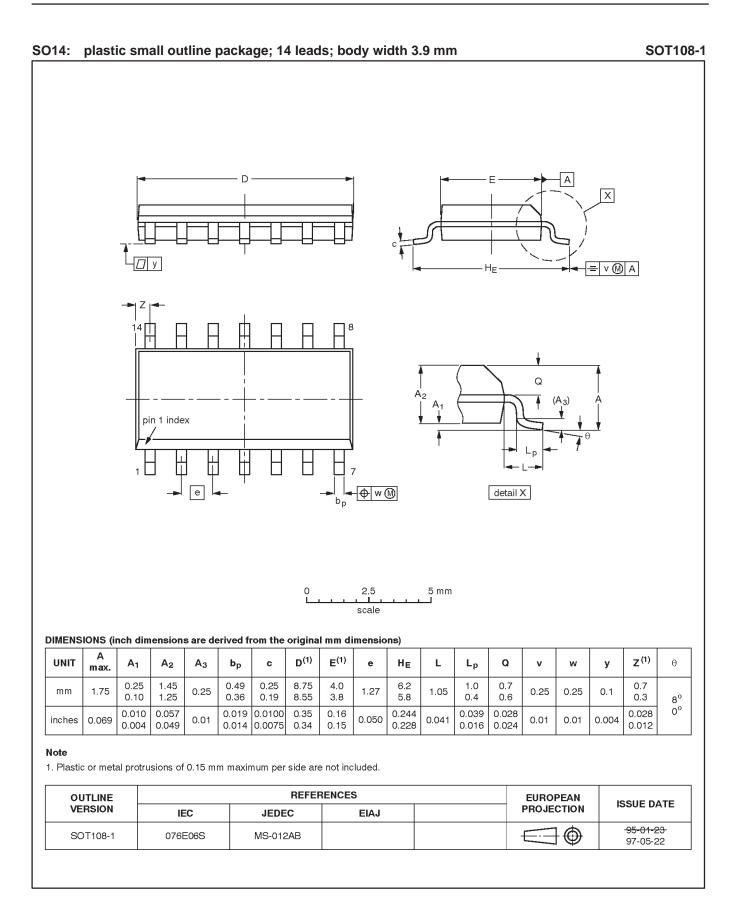
1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN		
VERSION	IEC	IEC JEDEC		PROJECTION	ISSUE DATE	
SOT27-1	050G04	MO-001AA			-92-11-17 95-03-11	

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SOT27-1

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Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
Product specification	Production	This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.

[1] Please consult the most recently issued datasheet before initiating or completing a design.

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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